

<b>Notice of References Cited</b>	Application/Control No. 10/676,340		Applicant(s)/Patent Under Reexamination FEENEY ET AL.	
	Examiner Ig T. An		Art Unit 3687	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,638,519 A	06-1997	Haluska, John E.	705/28
*	B	US-5,694,551 A	12-1997	Doyle et al.	705/26
*	C	US-6,029,143 A	02-2000	Mosher et al.	705/28
*	D	US-6,023,683 A	02-2000	Johnson et al.	705/26
*	E	US-6,173,210 B1	01-2001	Bjornson et al.	700/99
*	F	US-6,304,857 B1	10-2001	Heindel et al.	705/34
*	G	US-2002/0007326 A1	01-2002	Hashimoto et al.	705/28
*	H	US-2002/0099567 A1	07-2002	Joao, Raymond Anthony	705/1
*	I	US-6,505,094 B2	01-2003	Pape et al.	700/217
*	J	US-2003/0083890 A1	05-2003	Duncan et al.	705/1
*	K	US-6,611,727 B2	08-2003	Bickley et al.	700/99
*	L	US-2003/0208411 A1	11-2003	Estes et al.	705/26
*	M	US-6,947,903 B1	09-2005	Perry, Brian M.	705/28

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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